

Silicon Carbide Power MOSFET

N-Channel Enhancement Mode

Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness
- Halogen Free, RoHS Compliant

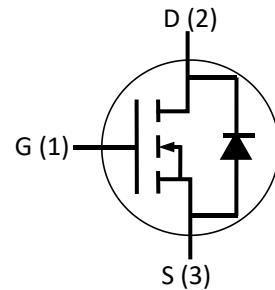
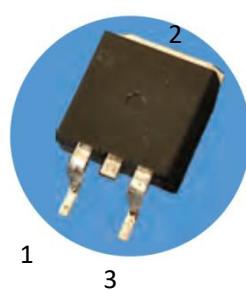
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- Battery Chargers
- Motor Drives
- Pulsed Power applications

Package



Part Number	Package
NF3M160120E	TO-263-2

Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DS\max}$	Drain - Source Voltage	1200	V	$V_{GS}=0\text{V}, I_D=100\mu\text{A}$	
$V_{GS\max}$	Gate - Source Voltage	-10/+25	V	Absolute maximum values	
V_{GSop}	Gate - Source Voltage	-5/+20	V	Recommended operational values	
I_D	Continuous Drain Current	17 11	A	$V_{GS}=20\text{V}, T_c=25^\circ\text{C}$ $V_{GS}=20\text{V}, T_c=100^\circ\text{C}$	
I_{DM}	Pulse Drain Current	38	A	Pulse width limited by $T_{j\max}$	
P_D	Power Dissipation	127	W	$T_c=25^\circ\text{C}, T_j=150^\circ\text{C}$	Fig. 10
T_j, T_{stg}	Operating Junction and Storage Temperature	-55 to +150	°C		

Electrical Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			V	V _{GS} =0V, I _D =100μA	
V _{GS(th)}	Gate Threshold Voltage	2.0	2.4	4.0	V	V _{GS} = V _{DS} , I _{DS} =2.5mA, T _C =25°C	Fig. 6
			1.8			V _{GS} = V _{DS} , I _{DS} =2.5mA, T _C =150°C	
I _{DSS}	Zero Gate Voltage Drain Current		1	100	μA	V _{DS} = 1200V, V _{GS} =0V	
I _{GSS}	Gate-Source Leakage Current		20	200	nA	V _{GS} =20V, V _{DS} = 0V	
R _{D(on)}	Drain-Source on-state Resistance		160	192	mΩ	V _{GS} =20V, I _D =10A, T _C =25°C	Fig. 4
			285			V _{GS} =20V, I _D =10A, T _C =150°C	
g _f s	Transconductance		4.2		S	V _{GS} = 20 V, I _D = 10A, T _J = 25 °C	Fig. 5
			4.0			V _{GS} = 20 V, I _D = 10A, T _J = 150 °C	
C _{iss}	Input Capacitance		950		pF	V _{GS} =0V, V _{DS} =1000 V, f=1MHz V _{AC} =25 mV	Fig. 8
C _{oss}	Output Capacitance		35.0				
C _{rss}	Reverse Transfer Capacitance		8.5				
E _{ON}	Turn-OnSwitching Energy		95		μJ	V _{DS} =800V, V _{GS} =-5/20V, I _D = 10A, R _{G(ext)} = 2.5Ω, L= 256μH	
E _{OFF}	Turn-Off Switching Energy		48				
t _{d(on)}	Turn-On Delay Time		12		ns	V _{DD} =800V, V _{GS} =-5/20 V I _D = 10A, R _{G(ext)} = 2.5 Ω , R _L =80Ω , Timing relative to V _{DS}	
t _r	Rise Time		20				
t _{d(off)}	Turn-Off Delay Time		15				
t _f	Fall Time		10				
R _{G(int)}	Internal Gate Resistance		5.8		Ω	f=1 MHz, V _{AC} =25mV	
Q _{gs}	Gate to Source Charge		9		nC	V _{DD} =800V, V _{GS} =-5/20 V I _D = 10A	Fig. 9
Q _{gd}	Gate to Drain Charge		17				
Q _g	Total Gate Charge		42				

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V _{SD}	Diode Forward Voltage	3.5		V	V _{GS} =-5V, I _{SD} = 5 A, T _J = 25 °C	Fig. 7
		3.3		V	V _{GS} =-5V, I _{SD} = 5 A, T _J = 150 °C	
I _S	Continuous Diode Forward Current		17	A	T _C = 25°C	
t _{rr}	Reverse Recovery time	14		ns	V _{GS} =-5V, I _{SD} = 10 A, V _R = 800V, dif/dt=1000A/μs;	
Q _{rr}	Reverse Recovery Charge	44		nC		
I _{rrm}	Peak Reverse Recovery Current	6.0		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
R _{θJC}	Thermal Resistance from Junction to Case	0.98	°C/W		Fig. 11
R _{θJA}	Thermal Resistance From Junction to Ambient	40			

Typical Performance

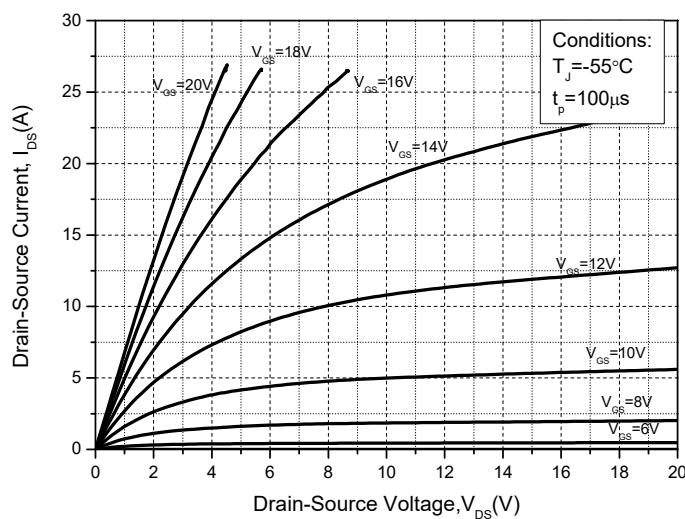


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

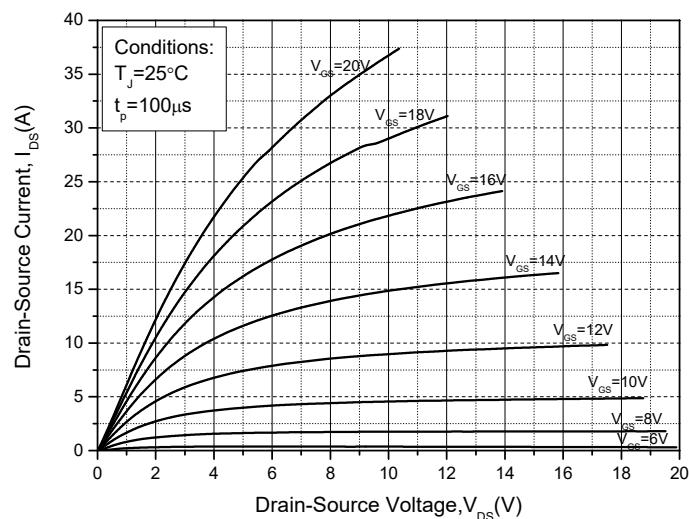


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

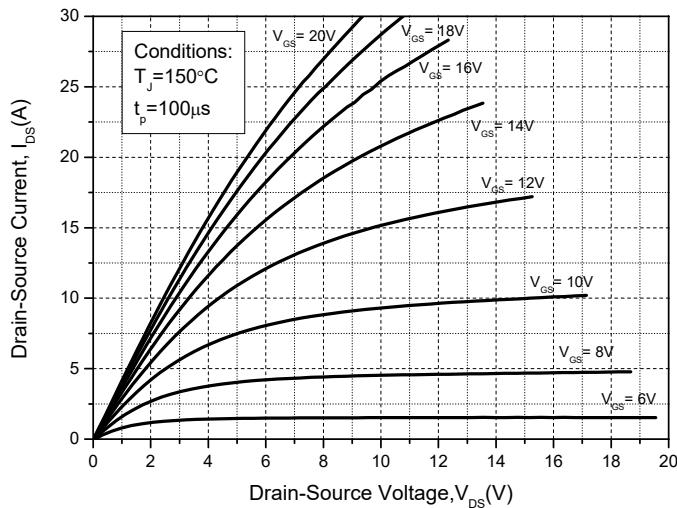


Figure 3. Output Characteristics $T_J = 150^\circ\text{C}$

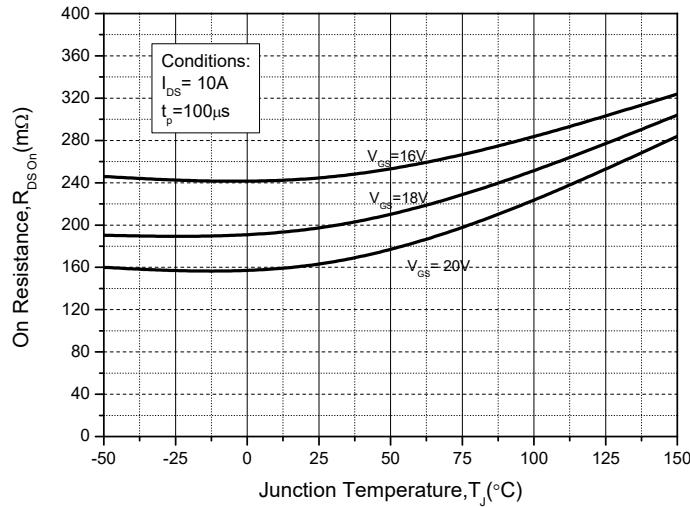


Figure 4. On-Resistance For Various Gate Voltage

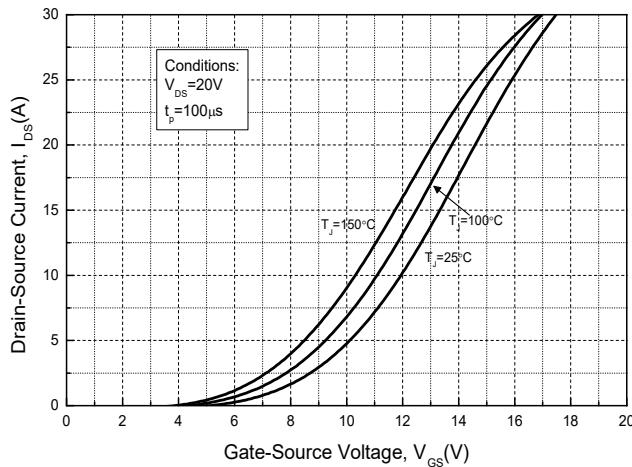


Figure 5. Transfer Characteristic

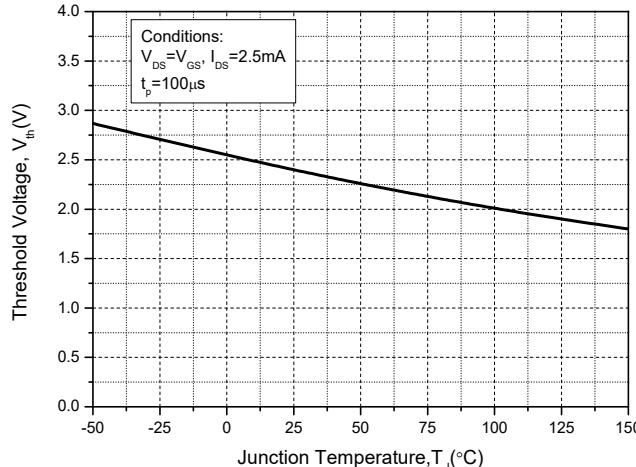


Figure 6. Threshold Voltage vs. TemperatureforVarious Junction Temperatures

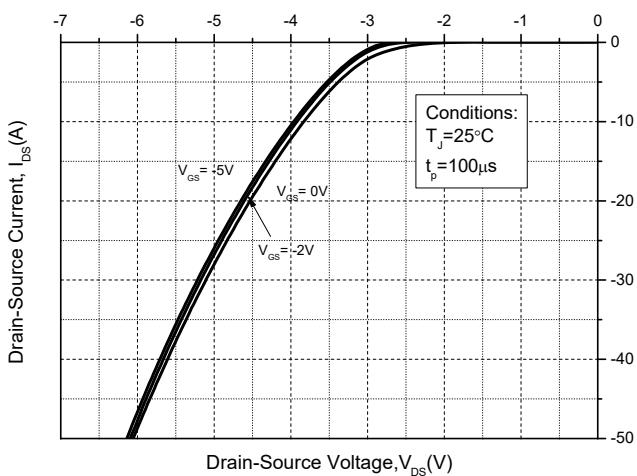


Figure 7. Body Diode Characteristics

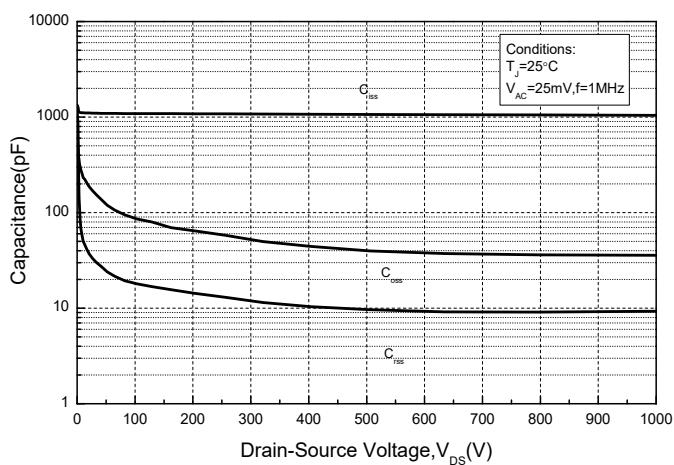


Figure 8. Capacitances vs. Drain-Source Voltage

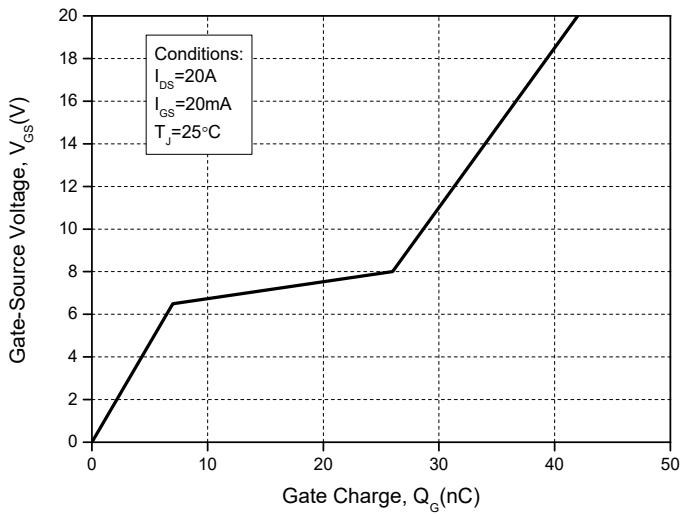


Figure 9. Gate Charge Characteristics

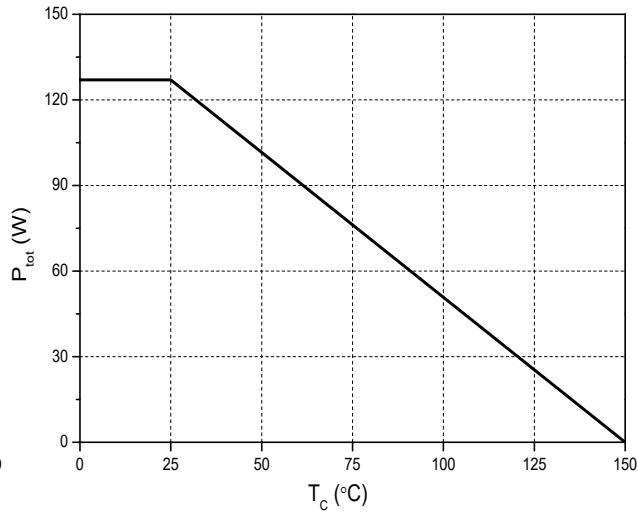


Figure 10. Power Dissipation Derating

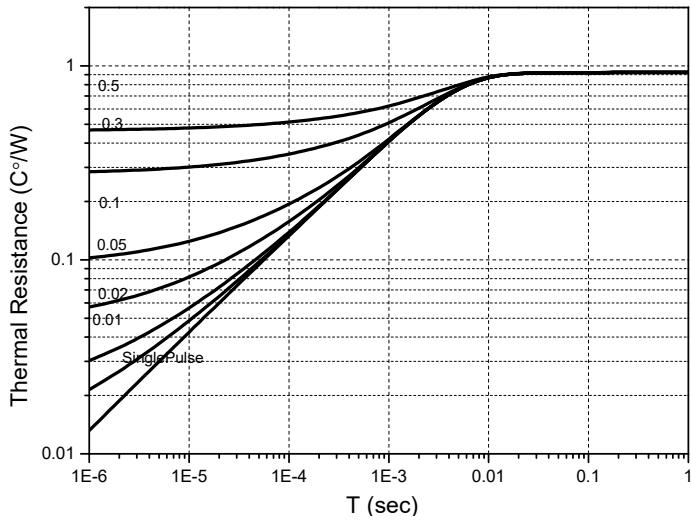
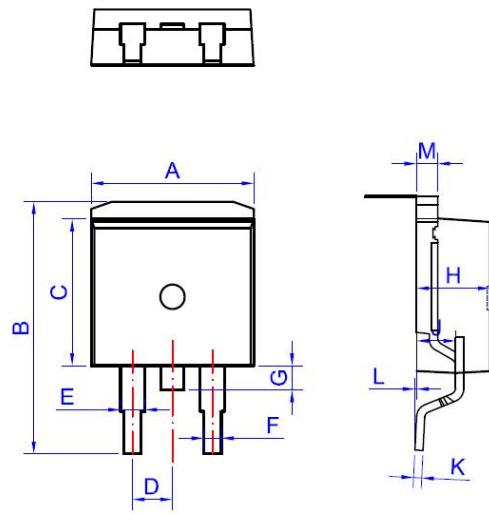


Figure 11. Transient Thermal Impedance

Package Dimensions: TO-263-2L



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	9.90		10.20	0.390		0.402
B	14.70		15.80	0.579		0.622
C	9.4		9.6	0.37		0.378
D		2.54			0.100	
E	1.20		1.40	0.047		0.055
F	0.75		0.85	0.029		0.033
G			1.75			0.069
H	4.40		4.70	0.173		0.185
J	2.30		2.70	0.091		0.106
K	0.38		0.55	0.015		0.022
L	0	0.10	0.25	0	0.004	0.010
M	1.25		1.35	0.049		0.053